

MOSFETs Silicon P-Channel MOS (U-MOSVI)

# SSM3J168F

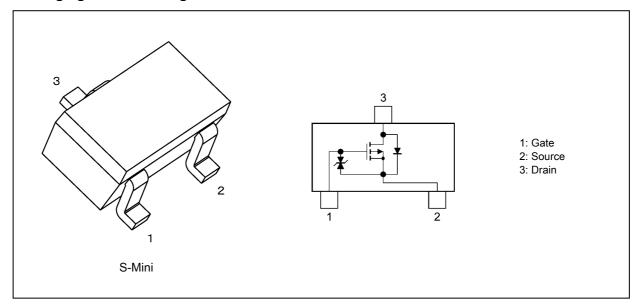
## 1. Applications

- · High-Speed Switching
- · Analog Switches
- · Interfacing

#### 2. Features

- (1) 4.0 V drive
- (2) Low drain-source on-resistance
  - :  $R_{DS(ON)} = 1.6 \Omega$  (typ.) ( $V_{GS} = -4.0 \text{ V}$ )
  - $R_{\rm DS(ON)} = 1.4 \ \Omega \ ({
    m typ.}) \ (V_{\rm GS} = -4.5 \ {
    m V})$
  - $R_{\mathrm{DS(ON)}} = 1.3~\Omega$  (typ.) ( $V_{\mathrm{GS}} = -10~\mathrm{V}$ )

#### 3. Packaging and Pin Assignment





## 4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

| Characteristics        |        |          | Symbol           | Rating     | Unit |
|------------------------|--------|----------|------------------|------------|------|
| Drain-source voltage   |        |          | $V_{DSS}$        | -60        | V    |
| Gate-source voltage    |        |          | V <sub>GSS</sub> | -20/+10    |      |
| Drain current (DC)     |        | (Note 1) | I <sub>D</sub>   | -400       | mA   |
| Drain current (pulsed) |        | (Note 1) | I <sub>DP</sub>  | -800       |      |
| Power dissipation      |        | (Note 2) | $P_D$            | 600        | mW   |
| Power dissipation      | t ≤ 1s | (Note 2) |                  | 1200       |      |
| Channel temperature    |        |          | T <sub>ch</sub>  | 150        | ů    |
| Storage temperature    |        |          | T <sub>stg</sub> | -55 to 150 |      |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Ensure that the channel temperature does not exceed 150 °C.

Note 2: Device mounted on a 25.4 mm × 25.4 mm × 1.6 mm FR4 glass epoxy board (Cu pad: 645 mm<sup>2</sup>)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.



#### 5. Electrical Characteristics

#### 5.1. Static Characteristics (Unless otherwise specified, Ta = 25 °C)

| Characteristics                |          | Symbol               | Test Condition   | Min  | Тур. | Max  | Unit |
|--------------------------------|----------|----------------------|--|------|------|------|------|
| Gate leakage current           |          | I <sub>GSS</sub>     | $V_{DS} = 0 \text{ V}, V_{GS} = -16 \text{ V}/+10 \text{ V}$ | _    | _    | ±10  | μА   |
| Drain cut-off current          |          | I <sub>DSS</sub>     | V <sub>DS</sub> = -60 V, V <sub>GS</sub> = 0 V               |      |      | -10  |      |
| Drain-source breakdown voltage |          | V <sub>(BR)DSS</sub> | $I_D = -1 \text{ mA}, V_{GS} = 0 \text{ V}$                  | -60  |      |      | V    |
| Drain-source breakdown voltage | (Note 1) | V <sub>(BR)DSX</sub> | $I_D = -1 \text{ mA}, V_{GS} = 10 \text{ V}$                 | -50  | _    |      |      |
| Gate threshold voltage         | (Note 2) | $V_{th}$             | $V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$              | -0.8 | _    | -2.0 |      |
| Drain-source on-resistance     | (Note 3) | R <sub>DS(ON)</sub>  | $I_D$ = -100 mA, $V_{GS}$ = -4.0 V                           | _    | 1.6  | 2.0  | Ω    |
|                                |          |                      | I <sub>D</sub> = -100 mA, V <sub>GS</sub> = -4.5 V           | _    | 1.4  | 1.9  |      |
|                                |          |                      | I <sub>D</sub> = -200 mA, V <sub>GS</sub> = -10 V            | _    | 1.3  | 1.55 |      |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

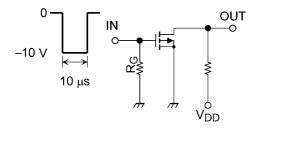
Take this into consideration when using the device.

Note 3: Pulse measurement.

## 5.2. Dynamic Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

| Characteristics                | Symbol           | Test Condition  | Min | Тур. | Max | Unit |
|--------------------------------|------------------|---|-----|------|-----|------|
| Input capacitance              | C <sub>iss</sub> | $V_{DS} = -10 \text{ V}$ , $V_{GS} = 0 \text{ V}$ ,   | _   | 82   | _   | pF   |
| Reverse transfer capacitance   | C <sub>rss</sub> | f = 1 MHz   | _   | 5.5  | _   |      |
| Output capacitance             | C <sub>oss</sub> |   |     | 13   |     |      |
| Switching time (turn-on time)  | t <sub>on</sub>  | $V_{DD} = -30 \text{ V}, I_D = -0.1 \text{ A},$ $V_{GS} = 0 \text{ to } -10 \text{ V}, R_G = 50 \Omega$         | _   | 4.3  | _   | ns   |
| Switching time (turn-off time) | t <sub>off</sub> | Duty $\leq$ 1 %,V <sub>IN</sub> : t <sub>r</sub> , t <sub>r</sub> < 5 ns,<br>Common source,<br>See Chapter 5.3. | _   | 31.7 | _   |      |

#### 5.3. Switching Time Test Circuit



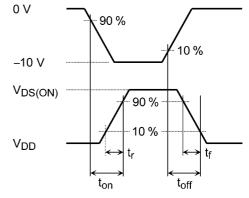


Fig. 5.3.1 Switching Time Test Circuit

Fig. 5.3.2 Input Waveform/Output Waveform

#### 5.4. Gate Charge Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

| Characteristics                                 | Symbol           | Test Condition                                    | Min | Тур. | Max | Unit |
|---|------------------|---|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | Qg               | $V_{DD} = -48 \text{ V}, I_{D} = -0.4 \text{ A},$ | _   | 3.0  | _   | nC   |
| Gate-source charge 1                            | Q <sub>gs1</sub> | V <sub>GS</sub> = -10 V                           | _   | 0.4  | _   |      |
| Gate-drain charge                               | Q <sub>gd</sub>  |   | _   | 1.1  | _   |      |

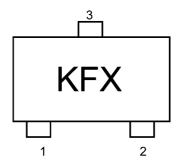


# 5.5. Source-Drain Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

| Characteristics          |         | Symbol    | Test Condition                 | Min | Тур. | Max | Unit |
|--------------------------|---------|-----------|--------------------------------|-----|------|-----|------|
| Diode forward voltage (N | Note 1) | $V_{DSF}$ | $I_D$ = 400 mA, $V_{GS}$ = 0 V |     | 0.87 | 1.2 | ٧    |

Note 1: Pulse measurement.

### 6. Marking



#### 7. Characteristics Curves (Note)

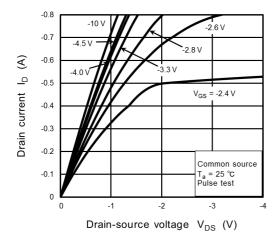
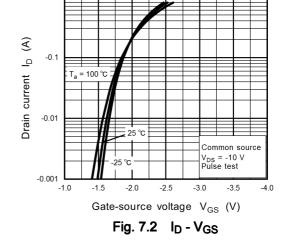


Fig. 7.1 I<sub>D</sub> - V<sub>DS</sub>



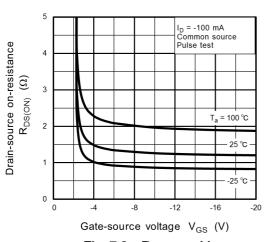


Fig. 7.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

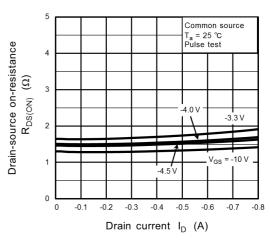


Fig. 7.4 R<sub>DS(ON)</sub> - I<sub>D</sub>

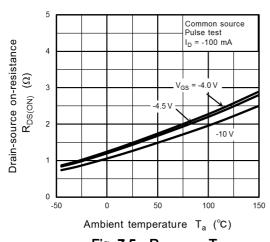


Fig. 7.5 R<sub>DS(ON)</sub> - T<sub>a</sub>

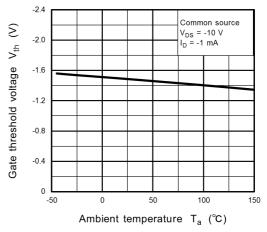


Fig. 7.6 V<sub>th</sub> - T<sub>a</sub>

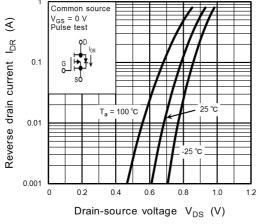


Fig. 7.7 IDR - VDS

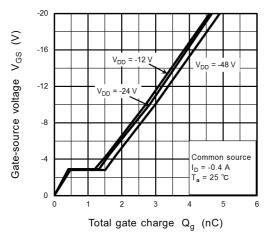


Fig. 7.9 Dynamic Input Characteristics

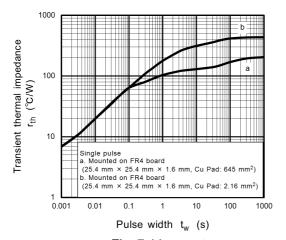


Fig. 7.11 r<sub>th</sub> - t<sub>w</sub>

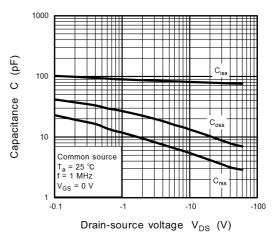


Fig. 7.8 C - V<sub>DS</sub>

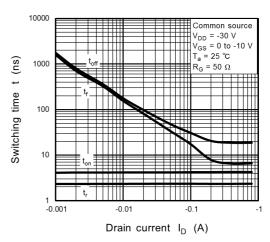


Fig. 7.10 t-I<sub>D</sub>

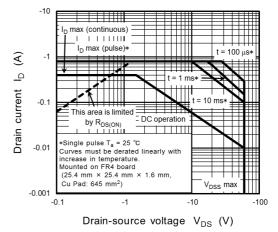


Fig. 7.12 Safe Operationg Area

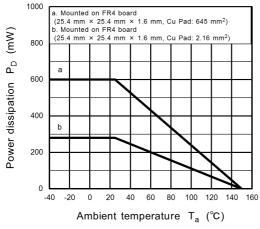


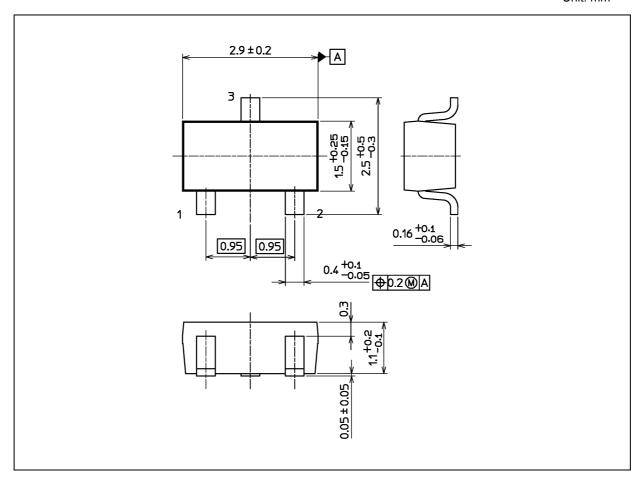
Fig. 7.13 P<sub>D</sub> - T<sub>a</sub>

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



## **Package Dimensions**

Unit: mm



Weight: 12 mg (typ.)

|                  | Package Name(s) |
|------------------|-----------------|
| JEDEC: SOT-346   |                 |
| Nickname: S-Mini |                 |



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